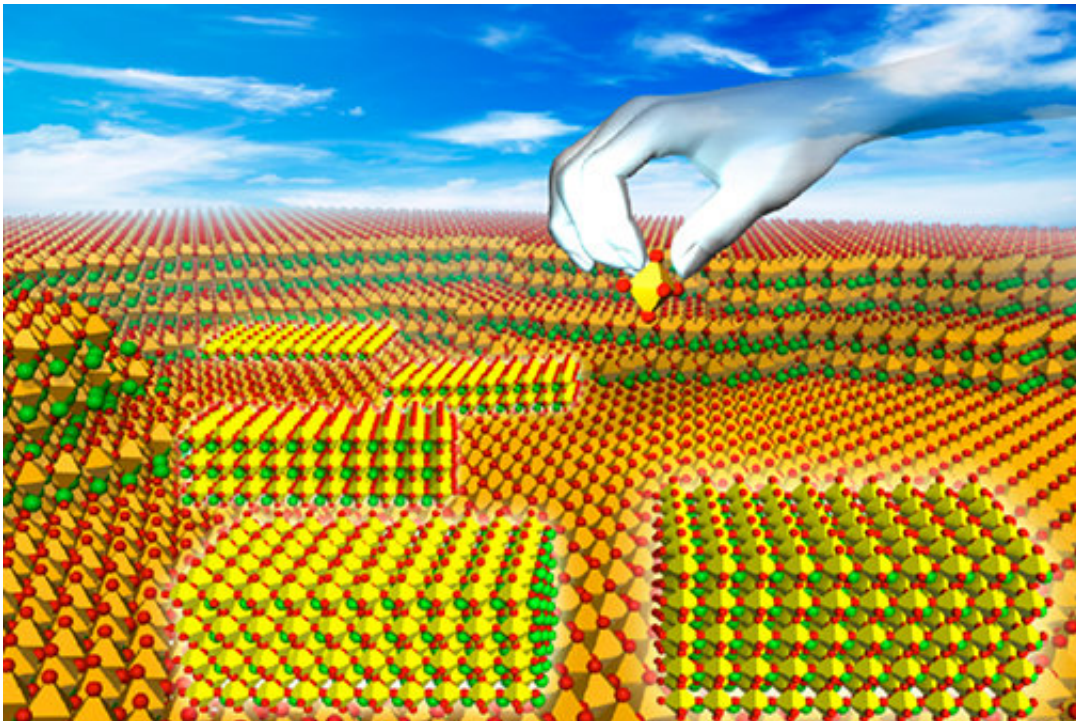


Atomically thin perovskites boost for future electronics

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Credit: National Institute for Materials Science

WPI-MANA has developed the world's highest performance dielectric nanofilms using atomically thin perovskites. This technology may revolutionize the next-generation of electronics.

This research was conducted by a WPI-MANA research group led by Principal Investigator Minoru Osada and Director Takayoshi Sasaki of

WPI-MANA at NIMS. Electronic devices are getting smaller all the time, but there is a limit to how small they can get using current materials and technology. High- κ [dielectric](#) materials may be the key for developing [electronic devices](#) of the future.

Minoru Osada and colleagues created high-performance dielectric nanofilms using 2-D perovskite nanosheets ($\text{Ca}_2\text{Na}_{m-3}\text{NbmO}_{3m+1}$; $m = 3-6$) as building blocks. Perovskite oxides offer tremendous potential for controlling their rich variety of electronic properties including high- κ dielectric and ferroelectric.

The researchers demonstrated the targeted synthesis of nanofilms composed of 2-D perovskite nanosheets in a unit-cell-upon-unit-cell manner. In this unique system, perovskite nanosheets enable precise control over the thickness of the perovskite layers in increments of ~ 0.4 nm (one perovskite unit) by changing m , and such atomic layer engineering enhances the high- κ dielectric response and local ferroelectric instability. The $m = 6$ member ($\text{Ca}_2\text{Na}_3\text{Nb}_6\text{O}_{19}$) attained the highest dielectric constant, $\epsilon_r = \sim 470$, ever realized in all known dielectrics in the ultrathin region of less than 10 nm.

Perovskite nanosheets are of technological importance for exploring high- κ dielectrics in 2-D materials, which have great potential in electronic applications such as memories, capacitors, and gate devices. Notably, [perovskite](#) nanosheets afforded high capacitances by relying on high- κ values at a molecular thickness. $\text{Ca}_2\text{Na}_3\text{Nb}_6\text{O}_{19}$ exhibited an unprecedented capacitance density of approximately $203 \mu\text{F cm}^{-2}$, which is about three orders of magnitude greater than that of currently available ceramic condensers, opening a route to ultra-scaled high-density capacitors.

These results provide a strategy for achieving 2-D high- κ dielectrics/ferroelectrics for use in ultra-scaled electronics and post-

graphene technology.

More information: Bao-Wen Li et al. Atomic Layer Engineering of High- κ Ferroelectricity in 2D Perovskites, *Journal of the American Chemical Society* (2017). [DOI: 10.1021/jacs.7b05665](https://doi.org/10.1021/jacs.7b05665)

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